

No.: KA/2020/42002 Date: 2020/05/14 Page: 1 of 6

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

The following sample(s) was/were submitted and identified by/on behalf of the applicant as:

Sample Submitted By : NITTO DENKO CORPORATION

Sample Description : MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Style/Item No. : NT-8500 SERIES

Sample Receiving Date : 2020/04/28

**Testing Period** : 2020/04/28 to 2020/05/04

: As specified by client, with reference to RoHS Directive 2011/65/EU Annex II to **Test Requested** 

determine Cadmium, Lead, Mercury, Cr(VI), PBBs, PBDEs contents in the submitted

sample.

Test Result(s) : Please refer to next page(s).

Ray Chang Ph.D. / Ma Signed for and on beh **SGS Taiwan Limited** Chemical Laboratory-Kad





No.: KA/2020/42002 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# Test Result(s)

PART NAME No.1 WHITE MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Test Item(s)	Unit	Method	MDL	Result
	Onit			No.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321-5: 2013 and performed by ICP-OES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321-5: 2013 and performed by ICP-OES.	2	n.d.
Mercury (Hg)	mg/kg	With reference to IEC 62321-4:2013+ AMD1:2017 and performed by ICP-OES.	2	n.d.
Hexavalent Chromium Cr(VI)	mg/kg	With reference to IEC 62321-7-2:2017 and performed by UV-VIS.	8	n.d.
Sum of PBBs			-	n.d.
Monobromobiphenyl			5	n.d.
Dibromobiphenyl			5	n.d.
Tribromobiphenyl			5	n.d.
Tetrabromobiphenyl		M/th(	5	n.d.
Pentabromobiphenyl	mg/kg	With reference to IEC 62321-6:2015 and performed by GC/MS.	5	n.d.
Hexabromobiphenyl			5	n.d.
Heptabromobiphenyl			5	n.d.
Octabromobiphenyl			5	n.d.
Nonabromobiphenyl			5	n.d.
Decabromobiphenyl			5	n.d.
Sum of PBDEs		With reference to IEC 62321-6:2015 and performed by GC/MS.	-	n.d.
Monobromodiphenyl ether			5	n.d.
Dibromodiphenyl ether			5	n.d.
Tribromodiphenyl ether			5	n.d.
Tetrabromodiphenyl ether			5	n.d.
Pentabromodiphenyl ether	mg/kg		5	n.d.
Hexabromodiphenyl ether			5	n.d.
Heptabromodiphenyl ether			5	n.d.
Octabromodiphenyl ether			5	n.d.
Nonabromodiphenyl ether			5	n.d.
Decabromodiphenyl ether			5	n.d.

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Page: 2 of 6



No.: KA/2020/42002 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

#### Note:

1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. " - " = Not Regulated

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Page: 3 of 6

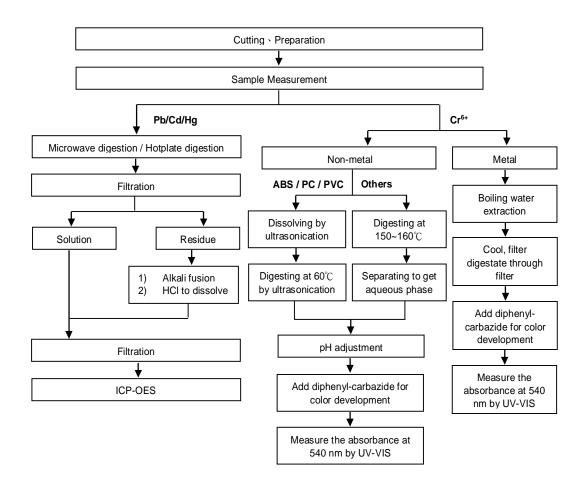


No.: KA/2020/42002 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# **Analytical flow chart of Heavy Metal**

These samples were dissolved totally by pre-conditioning method according to below flow chart. ( $Cr^{6+}$  test method excluded)



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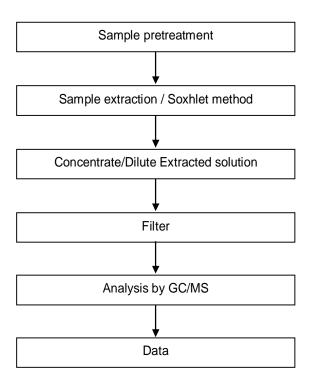
Page: 4 of 6



No.: KA/2020/42002 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

## PBB/PBDE analytical FLOW CHART



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Page: 5 of 6



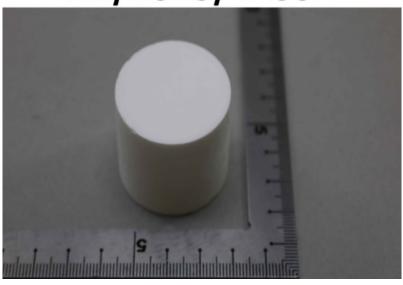
No.: KA/2020/42002

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*

Date: 2020/05/14

KA/2020/42002



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Page: 6 of 6



**Test Report** No.: KA/2020/51062 Date: 2020/05/14 Page: 1 of 4

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Submitted By NITTO DENKO CORPORATION

Sample Description MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

: NT-8500 SERIES Style/Item No.

Sample Receiving Date : 2020/05/11

**Testing Period** : 2020/05/11 to 2020/05/12

**Test Requested** : As specified by client, to test Halogen-Fluorine, Chlorine, Bromine, Iodine in the

submitted sample(s).

Test Result(s) : Please refer to next page(s).

Ray Chang Ph.D. / Signed for and on beh SGS Taiwan Limited Chemical Laboratory-Kaol



PIN CODE: 36AD61D9



**Test Report** No.: KA/2020/51062 Date: 2020/05/14 Page: 2 of 4

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

## Test Result(s)

PART NAME NO.1 : WHITE MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Test Item (s)	Unit	Method	MDL	Result
. ,				No.1
Halogen				
Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg	With reference to BS EN 14582:2016. Analysis was performed by IC.	50	n.d.
Halogen-Chlorine (CI) (CAS No.: 22537-15-1)	mg/kg	With reference to BS EN 14582:2016. Analysis was performed by IC.	50	602
Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	With reference to BS EN 14582:2016. Analysis was performed by IC.	50	n.d.
Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg	With reference to BS EN 14582:2016. Analysis was performed by IC.	50	n.d.

# Note:

1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected

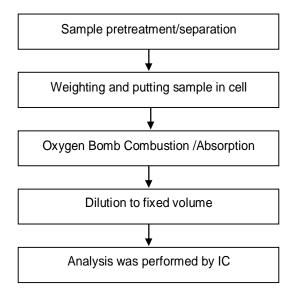
3. MDL = Method Detection Limit



**Test Report** No.: KA/2020/51062 Date: 2020/05/14 Page: 3 of 4

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

### Analytical flow chart of Halogen



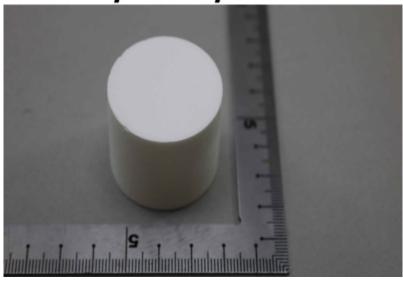


**Test Report** No.: KA/2020/51062 Date: 2020/05/14 Page: 4 of 4

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*

# KA/2020/51062



\*\* End of Report \*\*



**Test Report** Page: 1 of 4 No.: KA/2020/42018 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Submitted By : NITTO DENKO CORPORATION

MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR Sample Description

Style/Item No. : NT-8500 SERIES

Sample Receiving Date : 2020/04/28

**Testing Period** 2020/04/28 to 2020/05/04

\_\_\_\_\_\_

Test Result(s) Please refer to next page(s).

Ray Chang Ph.D. / Ma Signed for and on beh SGS Taiwan Limited Chemical Laboratory-Kao





**Test Report** No.: KA/2020/42018 Page: 2 of 4 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# Test Result(s)

PART NAME NO.1 : WHITE MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Test Item (s)	Unit	Method	MDL	Result
				No.1
Antimony (Sb)		With reference to US EPA 3052: 1996.	2	n.d.
		Analysis was performed by ICP-OES.		

#### Note:

1. mg/kg = ppm; 0.1wt% = 1000ppm2. MDL = Method Detection Limit

3. n.d. = Not Detected



No.: KA/2020/42018

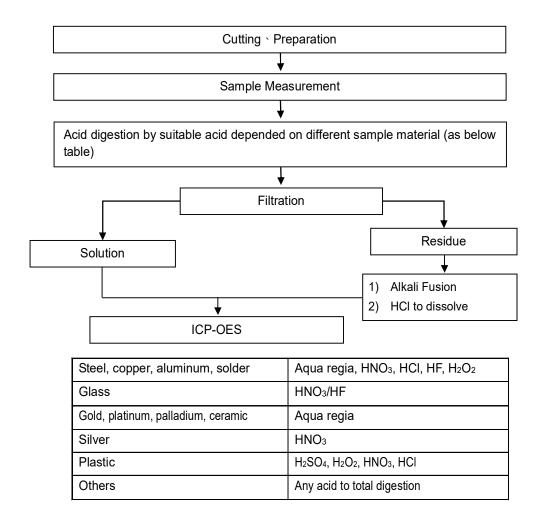
Date: 2020/05/14

Page: 3 of 4

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

## Flow Chart of digestion for the elements analysis performed by ICP-OES

These samples were dissolved totally by pre-conditioning method according to below flow chart.





**Test Report** Page: 4 of 4 No.: KA/2020/42018 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*

KA/2020/42018



\*\* End of Report \*\*



**Test Report** Page: 1 of 4 No.: KA/2020/42026 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Submitted By : NITTO DENKO CORPORATION

Sample Description : MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Style/Item No. : NT-8500 SERIES

Sample Receiving Date : 2020/04/28

**Testing Period** : 2020/04/28 to 2020/05/04

\_\_\_\_\_\_

Test Result(s) Please refer to next page(s).

Ray Chang Ph.D. / Ma Signed for and on beha SGS Taiwan Limited Chemical Laboratory-Kao

PIN CODE: 5AEC83AA



**Test Report** No.: KA/2020/42026 Page: 2 of 4 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# Test Result(s)

PART NAME NO.1 : WHITE MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Test Item (s)	Unit	Method	MDL	Result
rest item (s)	Oilit	Metriod		No.1
Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α-HBCDD, β-HBCDD, γ-HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))		With reference to IEC 62321: 2008. Analysis was performed by GC/MS.	5	n.d.

#### Note:

1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected

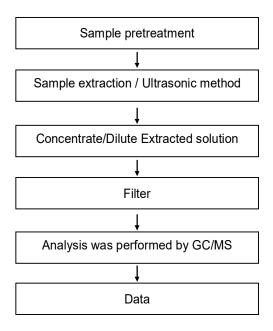
3. MDL = Method Detection Limit



**Test Report** No.: KA/2020/42026 Page: 3 of 4 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

### **HBCDD** analytical flow chart



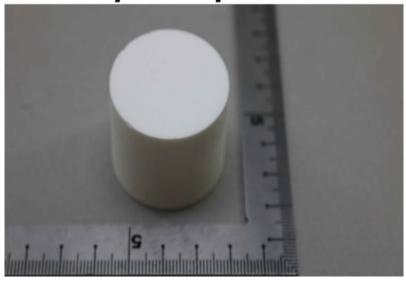


**Test Report** Page: 4 of 4 No.: KA/2020/42026 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*

# KA/2020/42026



\*\* End of Report \*\*



**Test Report** Page: 1 of 4 No.: KA/2020/42034 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

## The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Submitted By : NITTO DENKO CORPORATION

Sample Description MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Style/Item No. : NT-8500 SERIES

Sample Receiving Date : 2020/04/28

**Testing Period** : 2020/04/28 to 2020/05/04

: (1) As specified by client, with reference to RoHS 2011/65/EU Annex II and amending **Test Requested** 

Directive (EU) 2015/863 to determine DBP, BBP, DEHP, DIBP contents in the

submitted sample(s).

(2) Please refer to next pages for the other item(s).

Test Result(s) Please refer to next page(s).

Ray Chang Ph.D. / Ma Signed for and on beh SGS Taiwan Limited Chemical Laboratory-Kao

PIN CODE: 6C0789EE



**Test Report** No.: KA/2020/42034 Page: 2 of 4 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

# Test Result(s)

PART NAME NO.1 : WHITE MOLDING COMPOUND FOR OPTICAL SEMICONDUCTOR

Test Item (s)	Unit	Method	MDL	Result
rest item (s)	Oill	Wethou		No.1
Phthalates				
BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	mg/kg		50	n.d.
DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n.d.
DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg	With reference to IEC 62321-8:2017. Analysis was performed by GC/MS.	50	n.d.
DIDP (Di-isodecyl phthalate) (CAS No.: 26761-40-0; 68515-49-1)	mg/kg		50	n.d.
DINP (Di-isononyl phthalate) (CAS No.: 28553-12-0; 68515-48-0)	mg/kg		50	n.d.
DNOP (Di-n-octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n.d.
DIBP (Di-isobutyl phthalate) (CAS No.: 84-69-5)	mg/kg		50	n.d.

#### Note:

1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

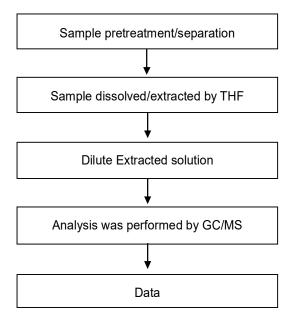


**Test Report** Page: 3 of 4 No.: KA/2020/42034 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

#### Analytical flow chart of phthalate content

[Test method: IEC 62321-8]





**Test Report** Page: 4 of 4 No.: KA/2020/42034 Date: 2020/05/14

NITTO DENKO CORPORATION 919, FUKE-CHO, KAMEYAMA, MIE, 519-0193, JAPAN

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*

# KA/2020/42034



\*\* End of Report \*\*